



**Agilent Technologies**

Sample ID:DT32\_B6\_3

Sample Scans:32

Background Scans:32

Resolution:4

System Status:Good

File Location:C:\Users\Public\Documents\Agilent\MicroLab\Results\Basic IR\DT32\_B6\_3\_2019-06-04T17-10-50.a2r

Method

Name:C:\Users\Public\Documents\Agilent\MicroLab\Methods\Basic IR.a2m

User:Generic User

Date/Time:06/04/2019 5:10:50 PM

Range:4000 - 650

Apodization:Happ-Genzel

